Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/639,071	ZHANG, KEVIN X.	
Examiner	Art Unit	
Christopher S. McCarthy	2113	

SEARCHED					
Class	Subclass	Date	Examiner		
714	53,54,48	7/12/2007	СМ		
711	128,13	7/12/2007	СМ		
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TNI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
Search Updated	7/12/2007	СМ
Inventor Name Search	7/12/2007	СМ